

## -20V P-Channel Enhancement Mode MOSFET

#### Description

The AP2307AI uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a Battery protection or in other Switching application.

#### **General Features**

 $V_{DS} = -20V I_{D} = -7A$ 

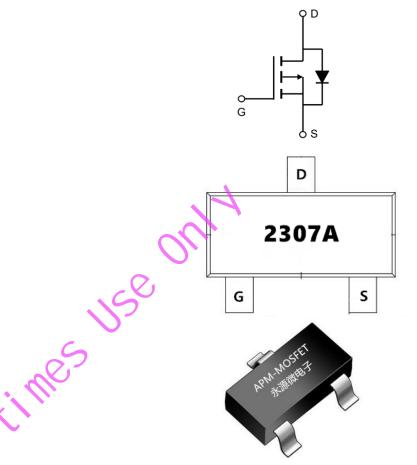
 $R_{DS(ON)} < 25m\Omega @ V_{GS} = -4.5V$  (Type:20m $\Omega$ )

#### Application

Quick charge

electronic cigarette

Uninterruptible power supply



#### Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)
AP2307AI	SOT23L	2307A	3000

#### Absolute Maximum Ratings (T<sub>A</sub>=25℃unless otherwise noted)

Symbol	Parameter	Rating	Units
VDS	Drain-Source Voltage	-20 V	
VGS	Gate-Source Voltage	±12	V
Id@T₄=25°C	Continuous Drain Current, V <sub>GS</sub> @ -4.5V <sup>1</sup>	-7	A
I <sub>D</sub> @T <sub>A</sub> =70°C	Continuous Drain Current, V <sub>GS</sub> @ -4.5V <sup>1</sup>	-4.8	A
Ідм	Pulsed Drain Current <sup>2</sup>	-23.8	A
P <sub>D</sub> @T <sub>A</sub> =25°C	Total Power Dissipation <sup>3</sup>	2	W
Тѕтс	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C
Reja	Thermal Resistance Junction-ambient <sup>1</sup>	62.5	°C/W
Rejc	Thermal Resistance Junction-Case <sup>1</sup>	80	°C/W

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#### Electrical Characteristics (TJ=25°C, unless otherwise noted)

Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Units
V(BR)DSS	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> = -250µA	-20	-22	-	V
IDSS	Zero Gate Voltage Drain Current	V <sub>DS</sub> = -20V, V <sub>GS</sub> =0V,	-	-	-1	μA
IGSS	Gate to Body Leakage Current	$V_{DS}$ =0V, $V_{GS}$ = ±12V	-	-	±100	nA
VGS(th)	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> = -250µA	-0.5	-0.7	-1.2	V
RDS(on)	Static Drain-Source on-Resistance note2	V <sub>GS</sub> = -4.5V, I <sub>D</sub> = -6A	-	20	25	
		V <sub>GS</sub> = -2.5V, I <sub>D</sub> = -5A	-	28	35	mΩ
Ciss	Input Capacitance		-	2000	-	pF
Coss	Output Capacitance	V <sub>DS</sub> = -10V, V <sub>GS</sub> =0V, f=1.0MHz		242	-	pF
Crss	Reverse Transfer Capacitance	$\sim$		231	-	pF
Qg	Total Gate Charge	V <sub>DS</sub> = -10V, I <sub>D</sub> = -3A, V <sub>GS</sub> = -4.5V	-	15.3	-	nC
$Q_{gs}$	Gate-Source Charge		-	2.2	-	nC
Q <sub>gd</sub>	Gate-Drain("Miller") Charge		-	4.4	-	nC
td(on)	Turn-on Delay Time		-	10	-	ns
tr	Turn-on Rise Time	V <sub>DD</sub> = -10V, I <sub>D</sub> = -7A, V <sub>GS</sub> = -4.5V,	-	31	-	ns
td(off)	Turn-off Delay Time	R <sub>GEN</sub> =2.5Ω	-	28	-	ns
t <sub>f</sub>	Turn-off Fall Time		-	8	-	ns
IS	Maximum Continuous Drain to Source Diode Forward Current		-	-	-7	А
ISM	Maximum Pulsed Drain to Source Diode Forward Current		-	-	-28	А
VSD	Drain to Source Diode Forward Voltage	V <sub>GS</sub> =0V, I <sub>S</sub> = -7A	-	-0.8	-1.2	V

#### Note :

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1. The data tested by surface mounted on a 1 inch2 FR-4 board with 2OZ copper.

2、The data tested by pulsed , pulse width  $\leq$  300us , duty cycle  $\leq$  2%

 $3\,{\scriptstyle \sim}\,$  The power dissipation is limited by 150  ${\rm ^{\circ}C}$  junction temperature

4. The data is theoretically the same as ID and IDM, in real applications, should be limited by total power dissipation.

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**Typical Characteristics** 

<u>AP2307AI</u>

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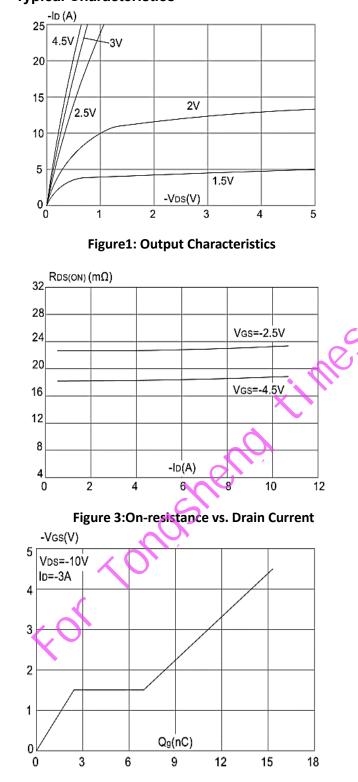
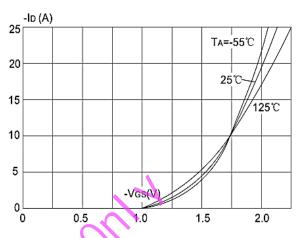
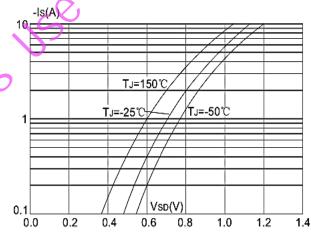


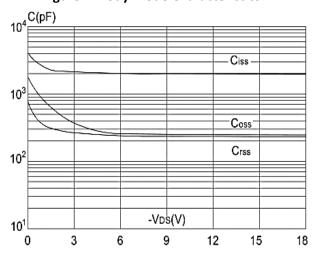
Figure 5: Gate Charge Characteristics



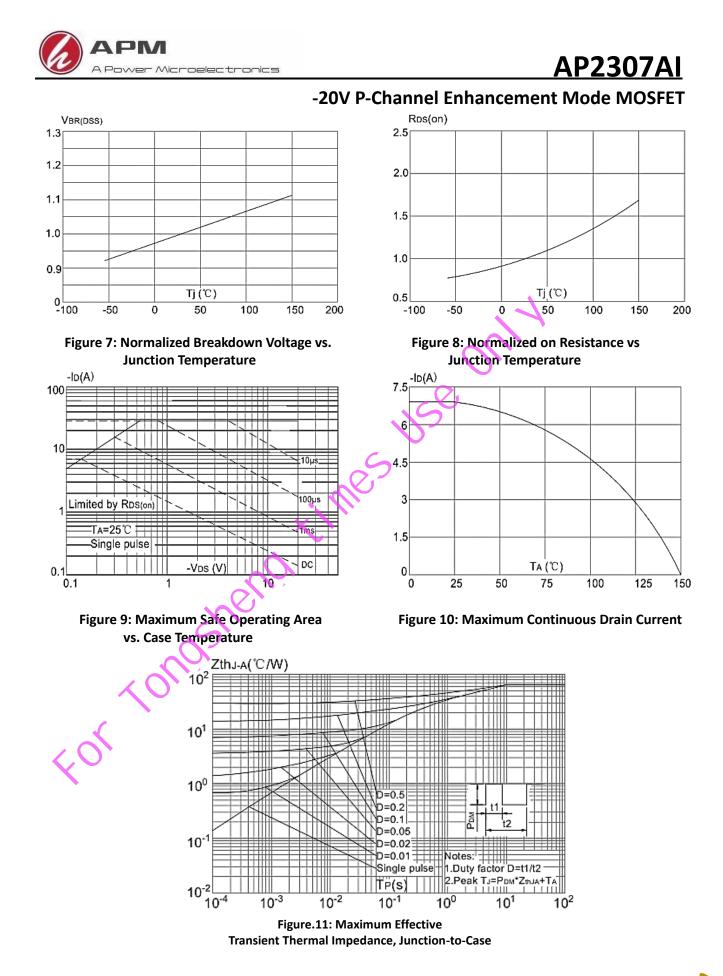
**Figure 2: Typical Transfer Characteristics** 



**Figure 4: Body Diode Characteristics** 



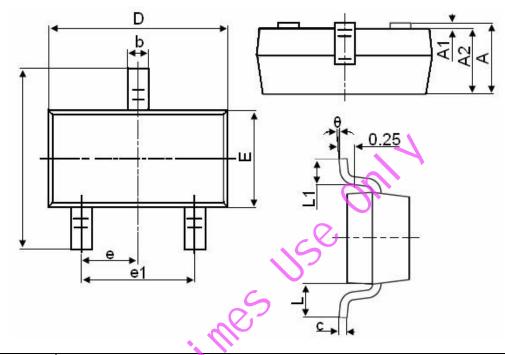
**Figure 6: Capacitance Characteristics** 





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## Package Mechanical Data-SOT23-XC-Single



Symbol	Dimensions in Millimeters	
Symbol	MIN.	MAX.
А	0.900	1.150
A1	0.000	0.100
A2	0.900	1.050
b	0.300	0.500
c	0.080	0.150
D	2.800	3.000
Æ	1.200	1.400
CE1	2.250	2.550
е	0.950TYP	
e1	1.800	2.000
L	0.550REF	
L1	0.300	0.500
θ	0°	8°



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### -20V P-Channel Enhancement Mode MOSFET

Edition	Date	Change
Rve1.0	2020/12/20	Initial release

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